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	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/814,229	CHUNG ET AL.
ĺ	Examiner	Art Unit
	William E. Tapolcai	3744

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Class	Subclass	Date	Examiner
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INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
62	340-356	1/3/2006	WET
62	66-74	1/3/2006	WET
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AST interference search	1/3/2006	WET